

# High-speed switching diode

## Features

1. Glass sealed envelope.
2. High reliability.
3. High speed.

## Applications

High speed switching

## Construction

Silicon epitaxial planar

## Absolute Maximum Ratings

T<sub>a</sub>=25°C

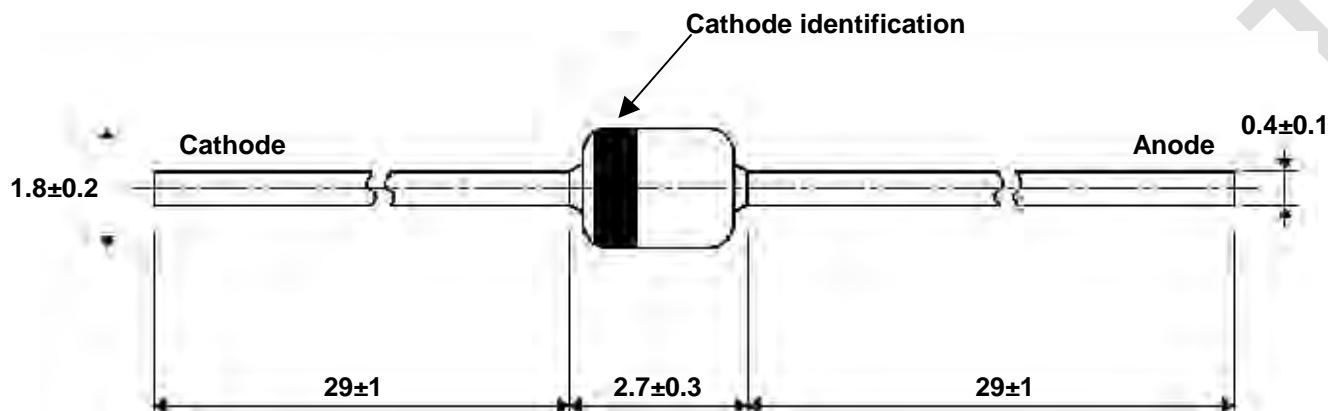
Parameter	Symbol	Limits	Unit	Parameter	Symbol	Value	Unit
Peak reverse voltage	V <sub>RM</sub>	90	V	Surge current(1s)	I <sub>surge</sub>	600	mA
DC reverse voltage	V <sub>R</sub>	80	V	Power dissipation	P	300	mW
Peak forward current	I <sub>FM</sub>	400	mA	Junction temperature	T <sub>j</sub>	175	°C
Mean rectifying current	I <sub>o</sub>	130	mA	Storage temperature	T <sub>stg</sub>	-65~+175	°C

## Electrical Characteristics

T<sub>a</sub>=25°C

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Forward voltage	V <sub>F</sub>	-	0.92	1.2	V	I <sub>F</sub> =100mA
Reverse current	I <sub>R</sub>	-	0.02	0.5	µ A	V <sub>R</sub> =80V
Capacitance between terminals	C <sub>T</sub>	-	1.55	2	pF	V <sub>R</sub> =0.5V,f=1MHz
Reverse recovery time	t <sub>rr</sub>	-	1.5	4	ns	V <sub>R</sub> =6V,I <sub>F</sub> =10mA,R <sub>L</sub> =50

## Dimensions in mm



Standard Glass Case  
JEDEC DO 34

## Characteristics ( $T_a=25^\circ\text{C}$ unless specified otherwise)

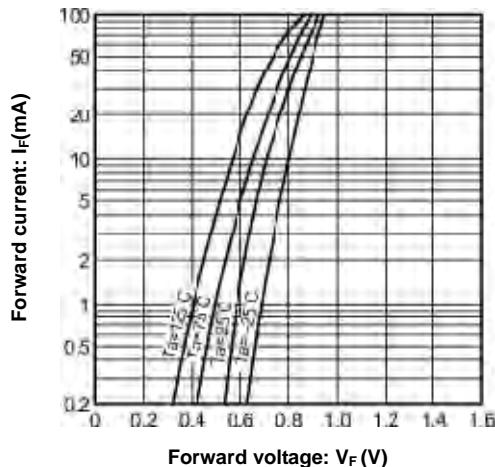


Figure 1. Forward characteristics

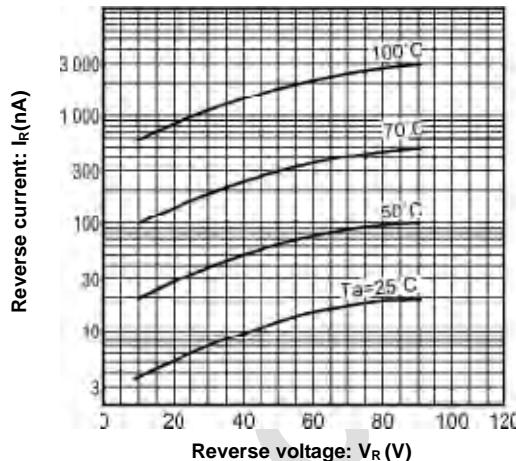


Figure 2. Reverse characteristics

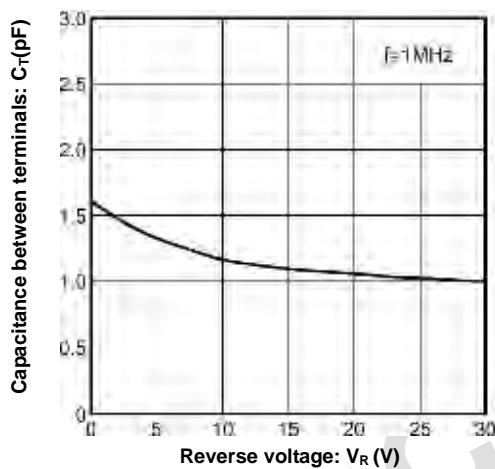


Figure 3. Capacitance between terminals characteristics

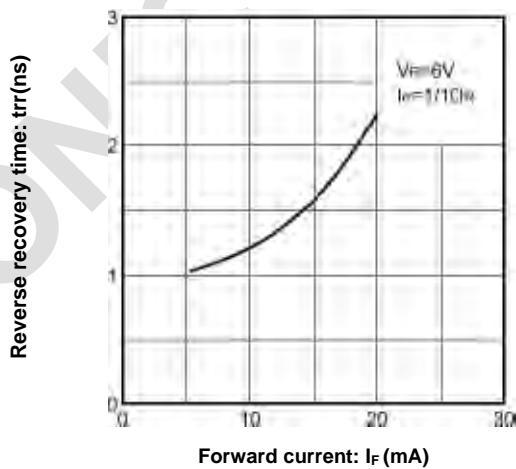


Figure 4. Reverse recovery time characteristics

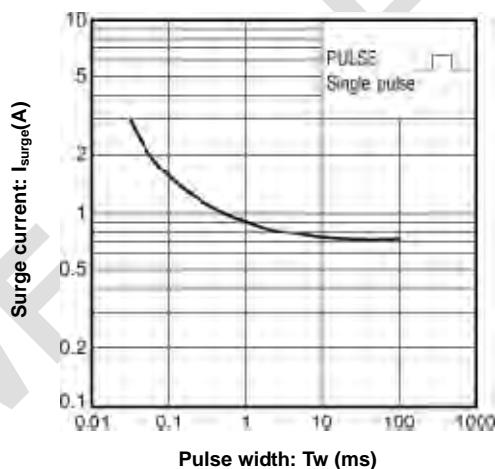


Figure 5. Surge current characteristics

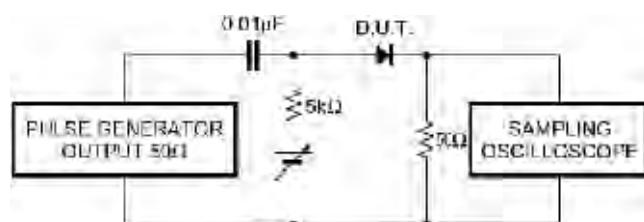


Figure 6. Reverse recovery time (trr) measurement circuit